



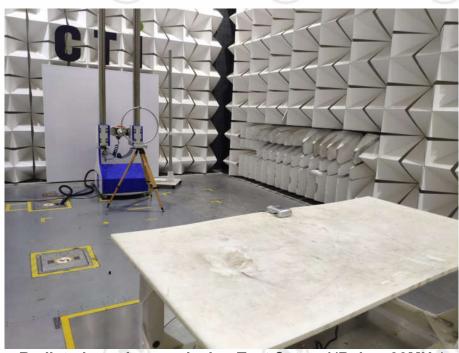




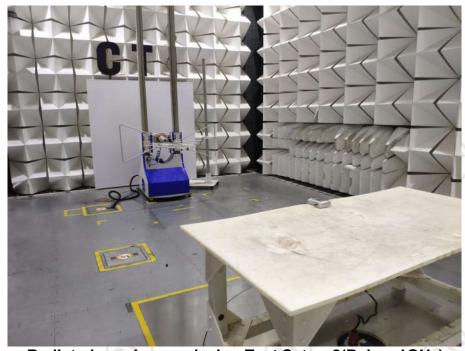
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## PHOTOGRAPHS OF TEST SETUP

Test model No.: BP3NQ1-4B



Radiated spurious emission Test Setup-1(Below 30MHz)



Radiated spurious emission Test Setup-2(Below 1GHz)





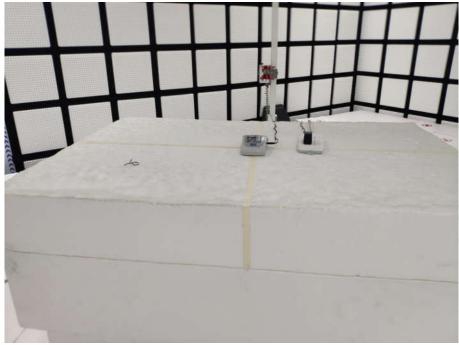




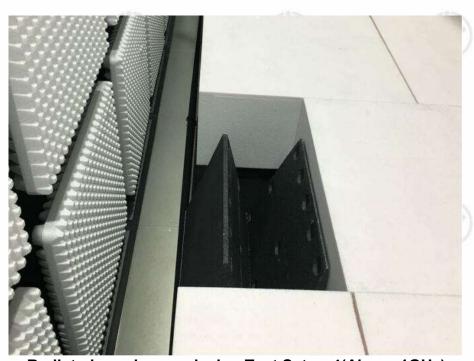




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Radiated spurious emission Test Setup-3(Above 1GHz)



Radiated spurious emission Test Setup-4(Above 1GHz)
There are absorbing materials under the ground.



















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